


Search Notes 	Application/Control No. 10576074	Applicant(s)/Patent Under Reexamination LEE ET AL.
	Examiner Audrey Y Chang	Art Unit 2872

SEARCHED			
Class	Subclass	Date	Examiner
359	571, 573, 569	10/2/2008	AC

SEARCH NOTES		
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EAST (search note)	10/2/2008	AC

INTERFERENCE SEARCH			
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